Se	arch No	ites

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/847,537	MATSUI ET AL.	
Examiner	Art Unit	
Thai Tran	2616	

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Class	Subclass	Date	Examiner
386	46	6/3/2005	TTQ
360	118-122	6/3/2005	TTQ
360	125	6/3/2005	TTQ
360	130.21	6/3/2005	TTQ
H04N	5/76	6/3/2005	TTQ
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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